



THE AMERICAN ASSOCIATION FOR
LABORATORY ACCREDITATION

ACCREDITED LABORATORY

A2LA has accredited

EVANS ANALYTICAL GROUP

Sunnyvale, CA

for technical competence in the field of

Chemical Testing

This laboratory is accredited in accordance with the recognized International Standard ISO/IEC 17025:2005 *General Requirements for the Competence of Testing and Calibration Laboratories*. This accreditation demonstrates technical competence for a defined scope and the operation of a laboratory quality management system (*refer to joint ISO-ILAC-IAF Communiqué dated January 2009*).



Presented this 10th day of February 2009.

A handwritten signature in cursive script, appearing to read "Peter Blinger".

President and CEO
For the Accreditation Council
Certificate Number 2797.01
Valid to February 28, 2011

For the tests or types of tests to which this accreditation applies,
please refer to the laboratory's Chemical Scope of Accreditation.



American Association for Laboratory Accreditation

SCOPE OF ACCREDITATION TO ISO/IEC 17025:2005

EVANS ANALYTICAL GROUP
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Sunnyvale, CA 94086
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CHEMICAL

Valid to: February 28, 2011

Certificate Number: 2797.01

In recognition of the successful completion of the A2LA evaluation process, accreditation is granted to this laboratory to perform analytical testing including contamination analysis, surface analysis and bulk compositional analysis on materials such as: semiconductors, integrated circuits, communication and storage devices, photovoltaic materials, optical components, thin film products, biomedical materials and products, pharmaceutical products, packaging materials, metals, alloys, plastics, polymers, glasses, powders and nanomaterials.

Tests

Test Methods

Secondary Ion Mass Spectrometry (SIMS)	ISO 17560, 14237; 18114 (SOP 8/F1); SEMI MF1528 (F2), 2139 (F4), 1366-0305 (F5), 1517-0304 (F6)
Rutherford Backscattering Spectrometry (RBS)	SOP 5/F1
X-Ray Photoelectron Spectroscopy (XPS)	SOP 11/F1
Auger Electron Spectroscopy (AES)	SOP 1/F1; ISO 21270; ASTM E827
Fourier Transform Infrared Spectroscopy (FTIR)	SOP 3/F1; ASTM E1252, E334
Raman Spectroscopy (Raman)	SOP 11/F1
Time-of-Flight Secondary Ion Mass Spectrometry (TOF-SIMS)	SOP 9/F1
Gas Chromatography Mass Spectrometry (GC/MS)	SOP 12/F1
Scanning Electron Microscopy / Energy Dispersive X-Ray Spectroscopy (SEM/EDS)	SOP 6/F1; ASTM E766
Atomic Force Microscopy (AFM)	SOP 2/F1

